

Notice of References Cited	Application/Control No. 10/711,637	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Tsz K. Chiu	Art Unit 2822	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,136,636	10-2000	Wu, Shye-Lin	438/231
*	B	US-6,891,192	05-2005	Chen et al.	257/49
*	C	US-2002/0079544	06-2002	Shino, Tomoaki	257/388
*	D	US-2003/0057439	03-2003	Fitzgerald, Eugene A.	257/192
*	E	US-6,121,100	09-2000	Andideh et al.	438/305
*	F	US-6,049,114	04-2000	Maiti et al.	257/412
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.